


<b>Search Notes</b> 	<b>Application/Control No.</b> 10531095	<b>Applicant(s)/Patent Under Reexamination</b> KRAUSE ET AL.
	<b>Examiner</b> Shin, Dana	<b>Art Unit</b> 1635

SEARCHED			
Class	Subclass	Date	Examiner
536	23.1	9-19-07, 10-17-07	DS
435	007.1, 488	9-19-07, 10-17-07	DS

SEARCH NOTES		
Search Notes	Date	Examiner
PALM - inventor name search	10-17-07	DS
EAST - search strategy attached	9-19-07, 10-17-07	DS
Wiley Interscience Online books - search terms: cloning, tag, spacer	10-17-07	DS
PubMed - search terms: "spacer" and "AAAAA"	11-1-07	DS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner